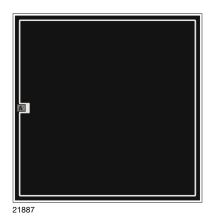


Vishay Semiconductors

Silicon PIN Photodiode

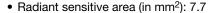


FEATURES

Package type: chip







· High photo sensitivity

· High radiant sensitivity

· Suitable for visible and near infrared radiation

Fast response times

• Angle of half sensitivity: $\varphi = \pm 60^{\circ}$

 Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>



DESCRIPTION

T1116P is a PIN photodiode with blue enhanced sensitivity and a 7.7 mm² sensitive area.

APPLICATIONS

• Blue enhanced photodetectors

GENERAL INFORMATION

The datasheet is based on Vishay optoelectronics sample testing under certain predetermined and assumed conditions, and is provided for illustration purpose only. Customers are encouraged to perform testing in actual proposed packaged and used conditions. Vishay optoelectronics die products are tested using Vishay optoelectronics based quality assurance procedures and are manufactured using Vishay optoelectronics established processes. Estimates such as those described and set forth in this datasheet for semiconductor die will vary depending on a number of packaging, handling, use, and other factors. Therefore sold die may not perform on an equivalent basis to standard package products.

PRODUCT SUMMARY				
COMPONENT	I _{ra} (μΑ)	φ (deg)	λ _{0.1} (nm)	
T1116P	43	± 60	350 to 1100	

Note

• Test conditions see table "Basic Characteristics"

ORDERING INFORMATION				
ORDERING CODE	PACKAGING	REMARKS	PACKAGE FORM	
T1116P-SD-F	Wafer sawn on foil with disco frame	MOQ: 3500 pcs	Chip	

Note

· MOQ: minimum order quantity

ABSOLUTE MAXIMUM RATINGS (T _{amb} = 25 °C, unless otherwise specified)				
PARAMETER	TEST CONDITION	SYMBOL	VALUE	UNIT
Reverse voltage		V _R	25	V
Junction temperature		T _j	100	°C
Operating temperature range		T _{amb}	-40 to +100	°C
Storage temperature range		T _{stg1}	-40 to +100	°C
Storage temperature range on foil		T _{sta2}	-40 to +50	°C

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BASIC CHARACTERISTICS (T _{amb} = 25 °C, unless otherwise specified)						
PARAMETER	TEST CONDITION	SYMBOL	MIN.	TYP.	MAX.	UNIT
Breakdown voltage	I _R = 100 μA, E = 0	V _(BR)	-	25	-	V
Forward voltage	I _F = 50 mA	V _F	-	1	1.3	V
Reverse dark current	V _R = 10 V, E = 0	I _{ro} t	-	2	5	nA
Diada canacitanas	V _R = 0 V, f = 1 MHz, E = 0	C _D	-	90	-	pF
Diode capacitance	$V_R = 3 V, f = 1 MHz, E = 0$	C _D	-	30	-	pF
Temperature coefficient of I _K	$E_{e} = 1 \text{ mW/cm}^{2}, \lambda = 950 \text{ nm}$	TK _{IK}	-	0.1	-	%/K
	$E_e = 1 \text{ mW/cm}^2, \lambda = 950 \text{ nm}, V_R = 5 \text{ V}$	I _{ra}	-	43	-	μΑ
Reverse light current	$E_e = 1 \text{ mW/cm}^2, \lambda = 400 \text{ nm}, V_R = 5 \text{ V}$	I _{ro}	-	13	-	μΑ
	$E_V = 100 \text{ lx}$, CIE illuminant A, $V_R = 5 \text{ V}$	I _{ro}	-	7.1	-	μΑ
Angle of half sensitivity		φ	-	± 60	-	deg
Wavelength of peak sensitivity		λ_{p}	-	940	-	nm
Range of spectral bandwidth		λ _{0.1}	-	350 to 1100	-	nm
Noise equivalent power	$V_R = 10 \text{ V}, \lambda = 400 \text{ nm}$	NEP	-	1.1 x 10 ⁻¹³	-	W/√Hz
Rise time	$V_R = 5 \text{ V}, R_L = 500 \ \Omega, \lambda = 850 \text{ nm}$	t _r	-	40	-	ns
Fall time	$V_R = 10 \text{ V}, R_L = 1 \text{ k}\Omega, \lambda = 820 \text{ nm}$	t _f	-	40	-	ns

Note

BASIC CHARACTERISTICS (T_{amb} = 25 °C, unless otherwise specified)

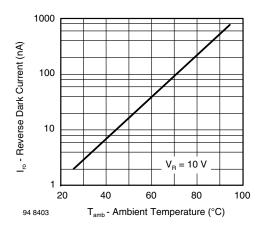


Fig. 1 - Reverse Dark Current vs. Ambient Temperature

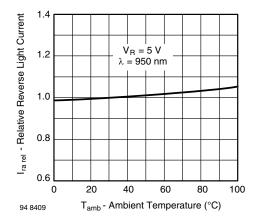


Fig. 2 - Relative Reverse Light Current vs. Ambient Temperature

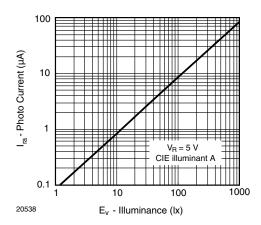


Fig. 3 - Photo Current vs. Illuminance

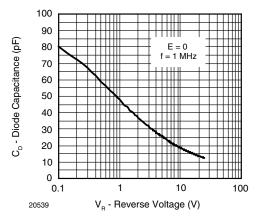


Fig. 4 - Diode Capacitance vs. Reverse Voltage

[·] The measurements are based on samples of die which are mounted on a TO-header without resin coating



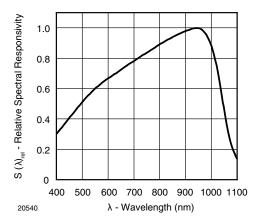


Fig. 5 - Relative Spectral Sensitivity vs. Wavelength

MECHANICAL DIMENSIONS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Length of chip edge (x-direction)	L _x	-	2.97	-	mm
Length of chip edge (y-direction)	L _y	-	2.97	-	mm
Sensitive area	A _S		2.77 x 2.77		mm ²
Die height	Н	-	0.28	-	mm
Bond pad anode	axb	-	0.125 x 0.110	=	mm ²

ADDITIONAL INFORMATION			
Frontside metallization, anode	Aluminum		
Backside metallization, cathode	NiV-Ag		
Dicing	Sawing		
Die bonding technology	Epoxy bonding		

Note

All chips are checked in accordance with the Vishay Semiconductor, specification of visual inspection FVOV6870.
The visual inspection shall be made in accordance with the "specification of visual inspection as referenced". The visual inspection of chip backside is performed with stereo microscope with incident light and 40x to 80x magnification.
The quality inspection (final visual inspection) is performed by production. An additional visual inspection step as special release procedure

HANDLING AND STORAGE CONDITIONS

- The hermetically sealed shipment lots shall be opened in temperature and moisture controlled cleanroom environment only. It is mandatory to follow the rules for disposition of material that can be hazardous for humans and environment.
- Product must be handled only at ESD safe workstations. Standard ESD precautions and safe work environments are as defined in MIL-HDBK-263.
- Singulated die are not to be handled with tweezers. A vacuum wand with non metallic ESD protected tip should be used.

PACKING

by QM is not installed.

Chips are fixed on adhesive foil. Upon request the foils can be mounted on plastic frame or disco frame. For shipment, the wafers are arranged to stacks and hermetically sealed in plastic bags to ensure protection against environmental influence (humidity and contamination).

Use for recycling reliable operators only. We can help getting in touch with your nearest sales office. By agreement we will take back packing material, if it is sorted. You will have to bear the costs of transport. We will invoice you for any costs incurred for packing material that is returned unsorted or which we are not obliged to accept.



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